

Composite Devices Silicon N-Channel MOS/Epitaxial Schottky Barrier

# SSM6H19NU

### 1. Applications

• DC-DC Converters

### 2. Features

(1) N-channel MOSFET and a schottky barrier diode in one package.

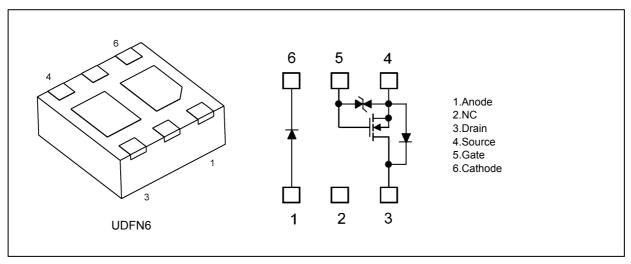
### 2.1. MOSFET Features

- (1) Low drain-source on-resistance
  - $: R_{DS(ON)} = 160 \text{ m}\Omega \text{ (typ.) } (@V_{GS} = 3.6 \text{ V})$
- (2) 1.8-V gate drive voltage.

### 2.2. Diode Features

(1) Low forward voltage:  $V_F = 0.51 \text{ V (typ.)}$  (@ $I_F = 500 \text{ mA}$ )

### 3. Packaging and Internal Circuit



### 4. Absolute Maximum Ratings (Note)

# 4.1. Absolute Maximum Ratings of the MOSFET (Unless otherwise specified, T<sub>a</sub> = 25 °C)

Characteristics		Symbol	Rating	Unit
Drain-source voltage		$V_{DSS}$	40	V
Gate-source voltage		$V_{GSS}$	±12	
Drain current	(Note 1)	I <sub>D</sub>	2.0	Α
Drain current (pulsed)	(Note 1)	I <sub>DP</sub>	4.0	
Channel temperature		T <sub>ch</sub>	150	°C

Note 1: Ensure that the channel temperature does not exceed 150  $^{\circ}\text{C}.$ 



# 4.2. Absolute Maximum Ratings of the Diode (Unless otherwise specified, $T_a$ = 25 °C)

Characteristics	Symbol	Rating	Unit
Reverse voltage	V <sub>R</sub>	40	V
Average rectified current	Io	500	mA
Non-repetitive peak forward surge current (t = 10 ms)	I <sub>FSM</sub>	5	Α
Junction temperature	Tj	125	°C

# 4.3. Absolute Maximum Ratings of the Common Section (Unless otherwise specified, T<sub>a</sub> = 25 °C)

	Characteristics		Symbol	Rating	Unit
Power dissipation		(Note 1)	$P_D$	1	W
Power dissipation	(t = 10 s)	(Note 1)		2	
Storage temperature			T <sub>stg</sub>	-55 to 150	°C

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 1: PD for the entire IC

Device mounted on a 25.4 mm  $\times$  25.4 mm  $\times$  1.6 mm FR-4 glass epoxy board (Cu pad: 645 mm<sup>2</sup>)

Note: The MOSFETs in this device are sensitive to electrostatic discharge. When handling this device, the worktables, operators, soldering irons and other objects should be protected against anti-static discharge.

Note: The channel-to-ambient thermal resistance, R<sub>th(ch-a)</sub>, and the drain power dissipation, P<sub>D</sub>, vary according to the board material, board area, board thickness and pad area. When using this device, be sure to take heat dissipation fully into account.

### 5. Electrical Characteristics

### 5.1. Static Characteristics of the MOSFET (Unless otherwise specified, Ta = 25 °C)

Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current		I <sub>GSS</sub>	$V_{GS} = \pm 10 \text{ V}, V_{DS} = 0 \text{ V}$	_	_	±10	μА
Drain cut-off current		I <sub>DSS</sub>	V <sub>DS</sub> = 40 V, V <sub>GS</sub> = 0 V	_	_	1	
Drain-source breakdown voltage		V <sub>(BR)DSS</sub>	I <sub>D</sub> = 1 mA, V <sub>GS</sub> = 0 V	40	_		V
Drain-source breakdown voltage	(Note 1)	V <sub>(BR)DSX</sub>	I <sub>D</sub> = 1 mA, V <sub>GS</sub> = -12 V	25	_		
Gate threshold voltage	(Note 2)	$V_{th}$	$V_{DS} = 3 \text{ V}, I_{D} = 1 \text{ mA}$	0.5	_	1.2	
Drain-source on-resistance	(Note 3)	R <sub>DS(ON)</sub>	I <sub>D</sub> = 1.0 A, V <sub>GS</sub> = 8.0 V	_	145	185	mΩ
			$I_D = 1.0 \text{ A}, V_{GS} = 4.5 \text{ V}$	_	155	198	
			$I_D = 1.0 \text{ A}, V_{GS} = 4.2 \text{ V}$	_	156	201	
			I <sub>D</sub> = 1.0 A, V <sub>GS</sub> = 3.6 V	_	160	208	
			I <sub>D</sub> = 0.5 A, V <sub>GS</sub> = 2.5 V	_	180	238	
			I <sub>D</sub> = 0.2 A, V <sub>GS</sub> = 1.8 V	_	220	390	
Forward transfer admittance	(Note 3)	Y <sub>fs</sub>	V <sub>DS</sub> = 3 V, I <sub>D</sub> = 200 mA	_	2		S

Note 1: If a reverse bias is applied between gate and source, this device enters  $V_{(BR)DSX}$  mode. Note that the drain-source breakdown voltage is lowered in this mode.

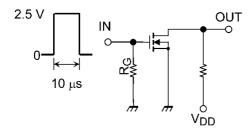
Note 2: Let  $V_{th}$  be the voltage applied between gate and source that causes the drain current ( $I_D$ ) to below (1 mA for this device). Then, for normal switching operation,  $V_{GS(ON)}$  must be higher than  $V_{th}$ , and  $V_{GS(OFF)}$  must be lower than  $V_{th}$ . This relationship can be expressed as:  $V_{GS(OFF)} < V_{th} < V_{GS(ON)}$ .

Take this into consideration when using the device.

Note 3: Pulse measurement.

### 5.2. Dynamic Characteristics of the MOSFET (Unless otherwise specified, T<sub>a</sub> = 25 °C)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Input capacitance	C <sub>iss</sub>	V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 0 V, f = 1 MHz	_	130	_	pF
Reverse transfer capacitance	C <sub>rss</sub>		_	7.5	_	
Output capacitance	Coss		_	26	_	
Switching time (turn-on time)	t <sub>on</sub>	$V_{DD} = 10 \text{ V}, I_D = 0.5 \text{ A},$	_	13	_	ns
Switching time (turn-off time)	t <sub>off</sub>	$V_{GS}$ = 0 V to 2.5 V, $R_{G}$ = 4.7 $\Omega$ , See Figure 5.2.1, 5.2.2.	_	8	_	



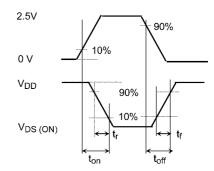


Fig. 5.2.1 Test Circuit of Switching Time

Fig. 5.2.2 Input Waveform/Output Waveform



# 5.3. Gate Charge Characteristics of the MOSFET (Unless otherwise specified, T<sub>a</sub> = 25 °C)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Total gate charge (gate-source plus gate-drain)	Qg	V <sub>DD</sub> = 10 V, I <sub>D</sub> = 1.8 A V <sub>GS</sub> = 4.2 V	_	1.1	2.2	nC
		V <sub>DD</sub> = 10 V, I <sub>D</sub> = 1.8 A V <sub>GS</sub> = 3.6 V		1.0	2.0	
		V <sub>DD</sub> = 10 V, I <sub>D</sub> = 1.8 A V <sub>GS</sub> = 2.5 V		0.75	1.5	

# 5.4. Source-Drain Characteristics of the MOSFET (Unless otherwise specified, T<sub>a</sub> = 25 °C)

Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit
Diode forward voltage	(Note 1)	$V_{DSF}$	$I_D = -2.0 \text{ A}, V_{GS} = 0 \text{ V}$		-0.85	-1.2	V

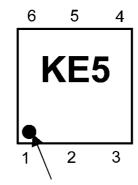
Note 1: Pulse measurement.



## 5.5. Characteristics of the Diode (Unless otherwise specified, T<sub>a</sub> = 25 °C)

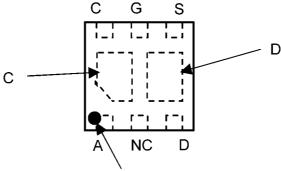
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Forward voltage	V <sub>F(1)</sub>	I <sub>F</sub> = 100 mA	_	0.31	0.35	V
	V <sub>F(2)</sub>	I <sub>F</sub> = 500 mA		0.51	0.57	
Reverse current	I <sub>R</sub>	V <sub>R</sub> = 40 V	_	_	50	μΑ
Total capacitance	Ct	V <sub>R</sub> = 0 V, f = 1 MHz		42		pF

## 6. Marking



Polarity marking

Fig. 6.1 Marking



Polarity marking (on the top)

\* Electrodes : on the bottom

Fig. 6.2 Pin Condition(Top View)

### 7. Characteristics Curves (Note)

### 7.1. Characteristics Curves of the MOSFET

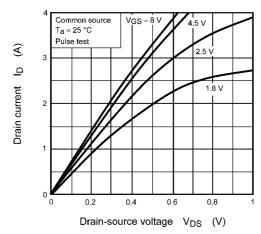


Fig. 7.1.1 I<sub>D</sub> - V<sub>DS</sub>

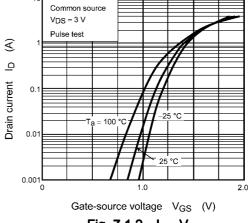


Fig. 7.1.2 I<sub>D</sub> - V<sub>GS</sub>

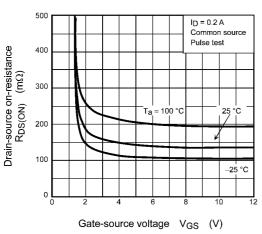


Fig. 7.1.3 R<sub>DS(ON)</sub> - V<sub>GS</sub>

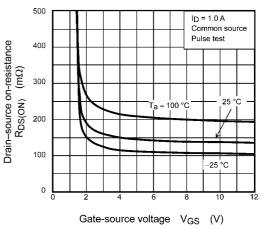


Fig. 7.1.4  $R_{DS(ON)}$  -  $V_{GS}$ 

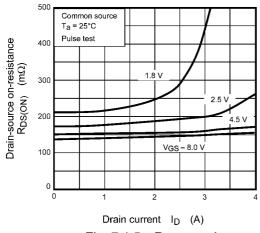


Fig. 7.1.5 R<sub>DS(ON)</sub> - I<sub>D</sub>

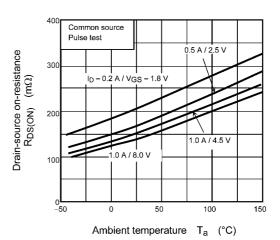
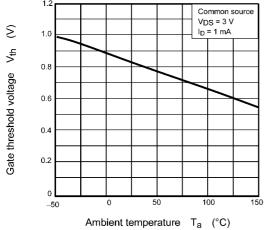


Fig. 7.1.6 R<sub>DS(ON)</sub> - T<sub>a</sub>



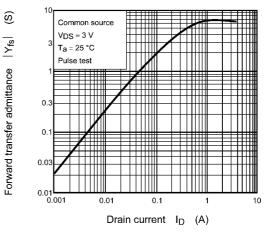


Fig. 7.1.7 V<sub>th</sub> - T<sub>a</sub>

Fig. 7.1.8 |Y<sub>fs</sub>| - I<sub>D</sub>

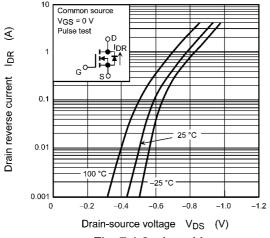


Fig. 7.1.9  $I_{DR}$  -  $V_{DS}$ 

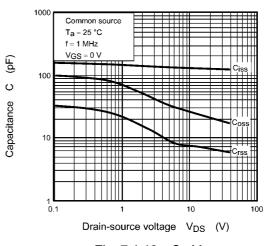
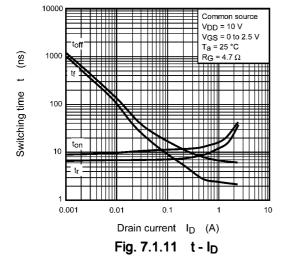


Fig. 7.1.10 C - V<sub>DS</sub>



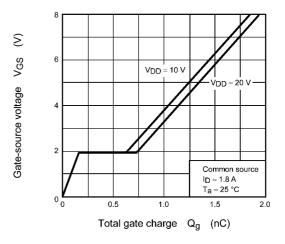


Fig. 7.1.12 Dynamic Input Characteristics



### 7.2. Characteristics Curves of the Diode

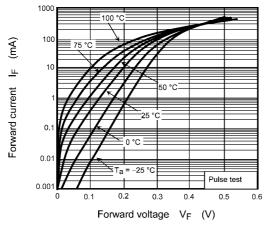


Fig. 7.2.1 I<sub>F</sub> - V<sub>F</sub>

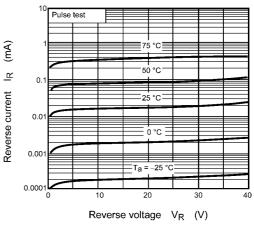


Fig. 7.2.2  $I_R - V_R$ 

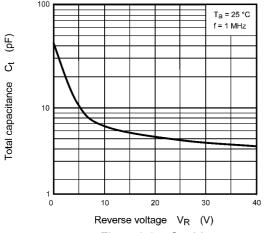


Fig. 7.2.3 Ct - VR



### 7.3. Characteristics Curves of the MOSFET · Diodes Common

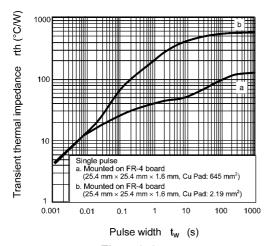


Fig. 7.3.1 r<sub>th</sub> - t<sub>w</sub>

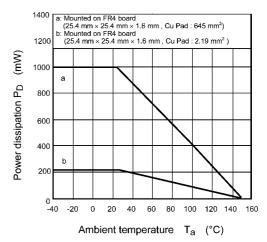


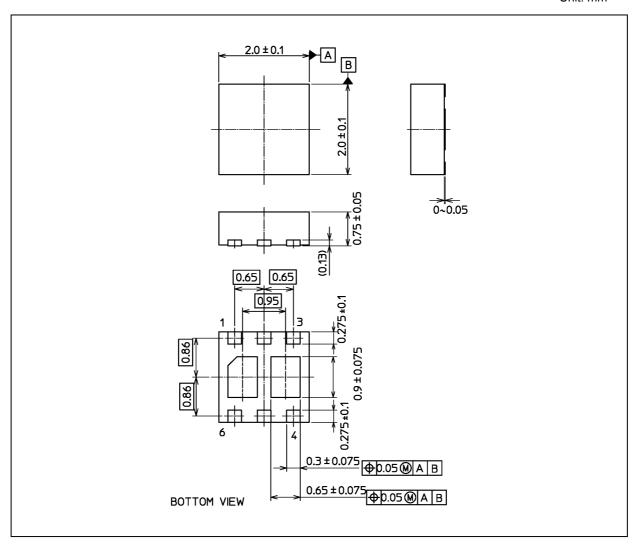
Fig. 7.3.2 PD - Ta

Note: The above characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.



## **Package Dimensions**

Unit: mm



Weight: 8.5 mg (typ.)

	Package Name(s)
Nickname: UDFN6	



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